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Application/Control N	o. Applicant(s)/Patent under Reexamination	
10/712,810	BLANCHARD ET AL.	
Examiner	Art Unit	
Thao X. Le	2814	

SEARCHED			
Class	Subclass	Date	Examiner
257	330-333 328-329 339	3/9/2006	TL
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INTERFERENCE SEARCHED			
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